

Notice of References Cited	Application/Control No. 09/995,328	Applicant(s)/Patent Under Reexamination BERTRAM ET AL.	
	Examiner Paul A. Zucker	Art Unit 1621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,473,079	12-1995	Heywang et al. <i>Duplicate of 1449</i>	
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	Q					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wang et al American Chemical Society, 220 th National Meeting, Abstract POLY-416, 2000.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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